Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/799,153	ISHIZAKA ET AL.
Examiner	Art Unit
John P. Sheehan	1742

John P. Sheehan

SEARCHED				
Class	Subclass	Date	Examiner	
		× .		
	(MA)			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
Search	3/27/2007	JPS		
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	Subclass	Subclass Date		

SEARCH N (INCLUDING SEARC		
	DATE	EXMR
EAST	12/11/2005	JPS
PALM Inventor Name Search	12/11/2005	JPS
EAST	6/13/2006	JPS
EAST	3/26/2007	JPS
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